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## IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

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Application Serial No	10/624,628
Filing Date	July 21, 2003
Inventor	Luan C. Tran
Assignee	Micron Technology, Inc.
	2812
Examiner	Kennedy, Jennifer M.
	MI22-2356
Title	Methods of Forming Semiconductor Constructions
1140	

## SUPPLEMENTAL INFORMATION DISCLOSURE STATEMENT

References -See Attached Form PTO-1449

The attached form PTO-1449 is submitted in compliance with 37 CFR §1.56. Copies of the cited art are included with the exception of U.S. patents and published U.S. applications (1276 OG 55). No admission is made regarding whether all the submitted references are prior art.

Respectfully submitted,

Dated:

By:

Jennifer J. Taylo

Reg. No. 48,711

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*Examiner Initial	,	Document Number	Date	Nam	ne	Class Subclass		Ī	Filing Date If Appropriate		
	АА	5,970,352	10/99	Shiozawa et	al.						
	AB	6,001,707	12/99	Lin et al.							
	AC	6,420,749	07/02	Divakaruni et	t al.						
	AD	6,187,624	02/01	Huang							
	AE	5,946,568	08/99	Hsiao et al.							
	AF	6,242,329	06/01	Huster et al.	,						
	AG	4,985,740	01/91	Shenai et al.							
	АН	US2002/0006693	01/02	Matsuda							
FOREIGN PATENT DOCUMENTS											
		Document	Date	Coun		Class	Sub	class	Tran	slation	
	!	Number				!			Yes	No	
	AP										
	AQ										
	AR										
	·	THER REFERENCES	S (includir	ng Author, Title	, Date, Perti	nent Par	ges, f	Etc.)			
	AS	F	Wolf et al Process 7	al., "Silicon Processing for the VLSI Era, Vol. 1: Technology," Second Edition, Lattice Press 2000, pp.12-							
	АТ		S.M. Sze, pages 472	, VLSI Technology, Second Edition, McGraw-Hill, 1988, 2-483							
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EXAMINER			DATE CON	DATE CONSIDERED							
*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this											

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form with next communication to applicant.